

MOS FIELD EFFECT TRANSISTOR $\mu PA1873$

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1873 is a switching device which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 2.5 V drive available
- $\label{eq:state} \begin{array}{l} \mbox{Low on-state resistance} \\ \mbox{R}_{DS(on)1} = 23.0 \mbox{ m}\Omega \mbox{ MAX.} (V_{GS} = 4.5 \mbox{ V}, \mbox{ ID} = 3.0 \mbox{ A}) \\ \mbox{R}_{DS(on)2} = 24.0 \mbox{ m}\Omega \mbox{ MAX.} (V_{GS} = 4.0 \mbox{ V}, \mbox{ ID} = 3.0 \mbox{ A}) \\ \mbox{R}_{DS(on)3} = 28.0 \mbox{ m}\Omega \mbox{ MAX.} (V_{GS} = 3.1 \mbox{ V}, \mbox{ ID} = 3.0 \mbox{ A}) \\ \mbox{R}_{DS(on)4} = 29.0 \mbox{ m}\Omega \mbox{ MAX.} (V_{GS} = 2.5 \mbox{ V}, \mbox{ ID} = 3.0 \mbox{ A}) \end{array}$
- Built-in G-S protection diode against ESD

ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA1873GR-9JG	Power TSSOP8

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

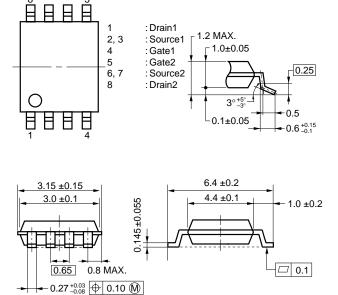
Drain to Source Voltage (Vgs = 0 V)	Vdss	20	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±12	V
Drain Current (DC) (T _A = 25°C)	D(DC)	±6.0	А
Drain Current (pulse) ^{Note1}	D(pulse)	±80	А
Total Power Dissipation (2 unit) Note2	Pτ	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

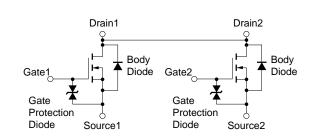
- 2. Mounted on ceramic substrate of 5000 mm² x 1.1 mm
- **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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PACKAGE DRAWING (Unit : mm)



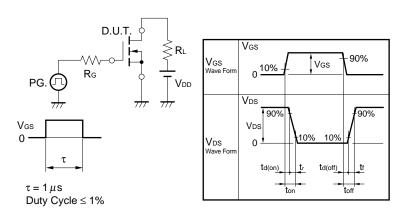
EQUIVALENT CIRCUIT



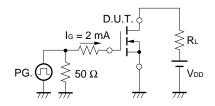
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	$V_{DS} = 20 V$, $V_{GS} = 0 V$			10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 12 V, V_{DS} = 0 V$			±10	μA
Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = 10 V, I_{D} = 1.0 mA$	0.5	1.0	1.5	V
Forward Transfer Admittance	y₁s	Vds = 10 V, Id = 3.0 A	5.0			S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = 4.5 V$, $I_D = 3.0 A$	13.0	18.0	23.0	mΩ
	RDS(on)2	$V_{GS} = 4.0 \text{ V}, \text{ Id} = 3.0 \text{ A}$	14.0	19.0	24.0	mΩ
	RDS(on)3	Vgs = 3.1 V, Id = 3.0 A	14.5	21.5	28.0	mΩ
	RDS(on)4	Vgs = 2.5 V, Id = 3.0 A	15.0	24.5	29.0	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		705		pF
Output Capacitance	Coss	Vgs = 0 V		205		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		145		pF
Turn-on Delay Time	td(on)	$V_{DD} = 10 V, I_D = 3.0 A$		60		ns
Rise Time	tr	V _{GS} = 4.0 V		310		ns
Turn-off Delay Time	td(off)	Rg = 10 Ω		380		ns
Fall Time	tr			420		ns
Total Gate Charge	QG	Vdd = 16 V		9.0		nC
Gate to Source Charge	Q _{GS}	Vgs = 4.0 V		2.0		nC
Gate to Drain Charge	Qgd	ID = 6.0 A		4.0		nC
Body Diode Forward Voltage	VF(S-D)	IF = 6.0 A, VGS = 0 V		0.84		V
Reverse Recovery Time	trr	IF = 6.0 A, VGS = 0 V		480		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A / μ s		1200		nC

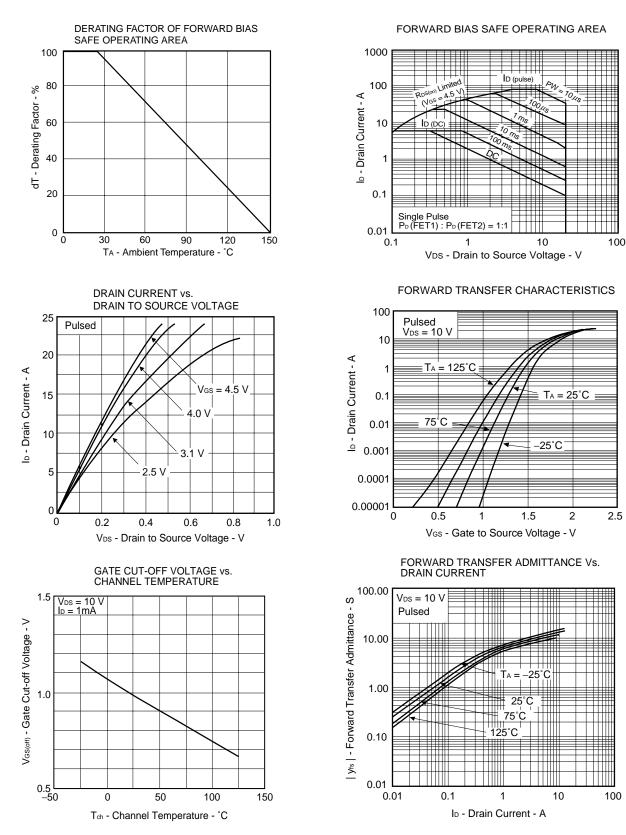
TEST CIRCUIT 1 SWITCHING TIME



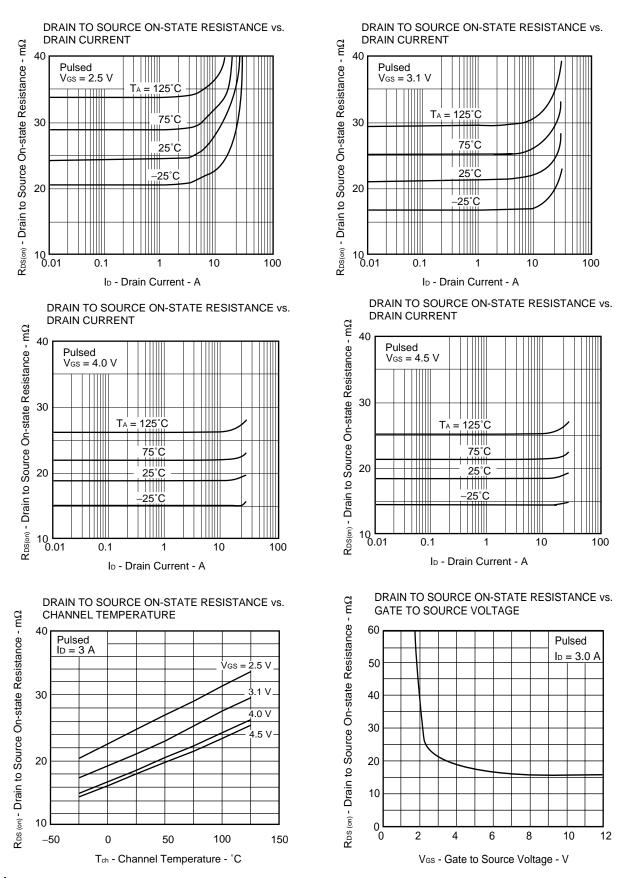
TEST CIRCUIT 2 GATE CHARGE



TYPICAL CHARACTERISTICS (TA = 25°C)



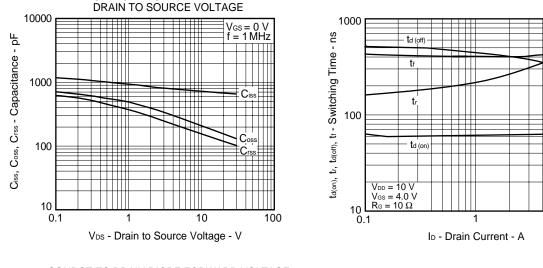
Data Sheet G15629EJ1V0DS



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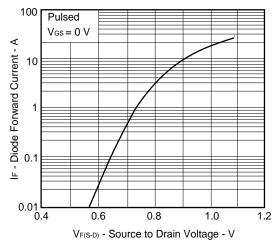
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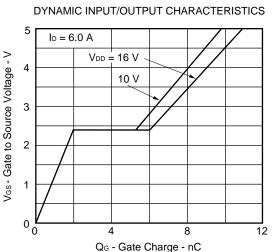




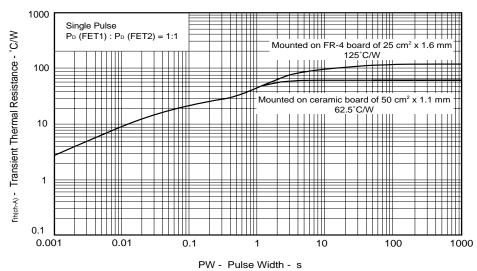
SOURCE TO DRAIN DIODE FORWARD VOLTAGE

CAPACITANCE vs.





TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



Data Sheet G15629EJ1V0DS

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